

DGG PACKAGE

(TOP VIEW)

FEATURES

- Member of Texas Instruments Widebus™ Family
- **OEC™** Circuitry Improves Signal Integrity and **Reduces Electromagnetic Interference**
- **D-Type Flip-Flops With Qualified Storage** Enable
- **Translates Between GTL/GTL+ Signal Levels** and LVTTL Logic Levels
- Supports Mixed-Mode (3.3 V and 5 V) Signal **Operation on A-Port and Control Inputs**
- I_{off} Supports Partial-Power-Down Mode Operation
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors on A Port
- Distributed V_{cc} and GND Pins Minimize **High-Speed Noise**
- Latch-Up Performance Exceeds 250 mA Per **JESD 17**
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)

DESCRIPTION/ORDERING INFORMATION

The SN74GTL16622A is an 18-bit registered bus transceiver that provides LVTTL-to-GTL/GTL+ and GTL/GTL+-to-LVTTL signal-level translation. This device is partitioned as two separate 9-bit transceivers with individual clock-enable controls and contains D-type flip-flops for temporary storage of data flowing in either direction. This device provides an interface between cards operating at LVTTL logic levels and a backplane operating at GTL/GTL+ signal levels. Higher-speed operation is a direct result of the reduced output swing (<1 V), reduced input threshold levels, and OEC[™] circuitry.

	(,	
OEAB		U	հ	CLKAB
1A1		64 63		1CEAB
GND		62	ь	1CEBA
1A2		61	E	1B1
1A3		60	ь	GND
GND		59	_	1B2
V _{CC}	ď7	58	ь	1B3
1A4		57	ь	V _{CC}
GND	Ĭ9	56	Б	1B4
1A5			_	1B5
1A6	11			1B6
GND	1 12			GND
1A7	1 13		F.	1B7
1A8	14		Б	1B8
GND	15		Б	GND
1A9	16	6 49	þ	1B9
2A1	[17	' 48	þ	2B1
GND	18	8 47	þ	GND
2A2	[19	9 46	þ	2B2
2A3	20) 45	þ	2B3
GND	21	44	μ	GND
2A4	22	2 43	μ	2B4
2A5	23		β	2B5
GND	24	41	ρ	2B6
2A6	25	5 40	ρ	V_{REF}
V _{CC}	26	39	μ	2B7
GND	27	38	D	2B8
2A7	28		0	GND
2A8	29		D	2B9
GND	30		þ	2CEBA
2A9	31	-	E	2CEAB
OEBA	32	2 33	μ	CLKBA

The user has the flexibility of using this device at either GTL ($V_{TT} = 1.2$ V and $V_{REF} = 0.8$ V) or the preferred higher noise margin GTL+ ($V_{TT} = 1.5$ V and $V_{REF} = 1$ V) signal levels. GTL+ is the Texas Instruments derivative of the Gunning Transceiver Logic (GTL) JEDEC standard JESD 8-3. The B port normally operates at GTL or GTL+ signal levels, while the A-port and control inputs are compatible with LVTTL logic levels and are 5-V tolerant. V_{REF} is the reference input voltage for the B port.

Data flow in each direction is controlled by the output-enable (OEAB and OEBA) and clock (CLKAB and CLKBA) inputs. The clock-enable (CEAB and CEBA) inputs control each 9-bit transceiver independently, which makes the device more versatile.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet. Widebus, OEC are trademarks of Texas Instruments.

SCBS673F-AUGUST 1996-REVISED APRIL 2005

DESCRIPTION/ORDERING INFORMATION (CONTINUED)

For A-to-B data flow, the device operates on the low-to-high transition of CLKAB if CEAB is low. When OEAB is low, the outputs are active. When OEAB is high, the outputs are in the high-impedance state. Data flow for B to A is similar to that of A to B, but uses OEBA, CLKBA, and CEBA.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

Active bus-hold circuitry holds unused or undriven LVTTL inputs at a valid logic state. Use of pullup or pulldown resistors with the bus-hold circuitry is not recommended.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

ORDERING INFORMATION

T _A	PACKA	AGE ⁽¹⁾	ORDERABLE PART NUMBER	TOP-SIDE MARKING
–40°C to 85°C	TSSOP – DGG	Tape and reel	SN74GTL16622ADGGR	GTL16622A

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

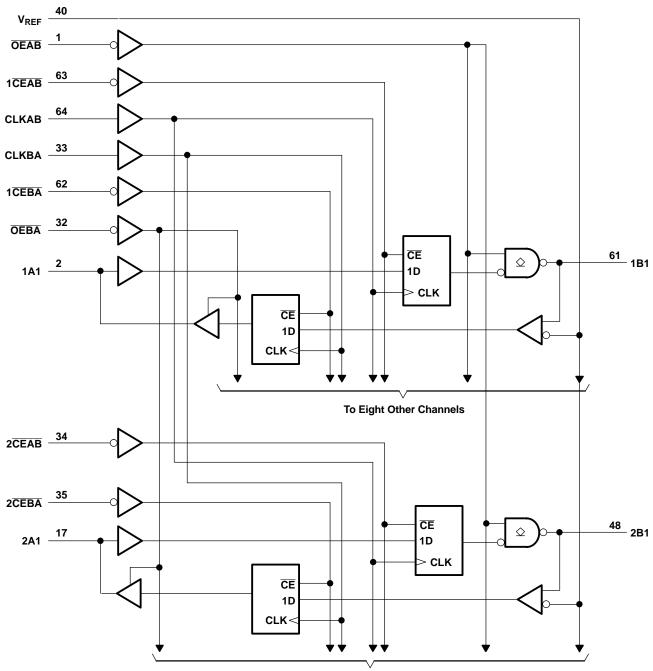
	INP	UTS		OUTPUT	MODE
CEAB	OEAB	CLKAB	Α	В	MODE
Х	Н	Х	Х	Z	Isolation
Н	L	Х	Х	B ₀ ⁽²⁾	Latebad starses of A data
Х	L	H or L	Х	B ₀ ⁽²⁾	Latched storage of A data
L	L	\uparrow	L	L	Cleaked starses of A data
L	L	\uparrow	н	н	Clocked storage of A data

FUNCTION TABLE⁽¹⁾

(1) A-to-B data flow is shown. B-to-A data flow is similar, but uses OEBA, CLKBA, and CEBA.

(2) Output level before the indicated steady-state input conditions are established

SCBS673F-AUGUST 1996-REVISED APRIL 2005



LOGIC DIAGRAM (POSITIVE LOGIC)

To Eight Other Channels

SCBS673F-AUGUST 1996-REVISED APRIL 2005

Absolute Maximum Ratings⁽¹⁾

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V_{CC}	Supply voltage range				
V	Input voltage range ⁽²⁾	A-port and control inputs	-0.5	6.5	V
VI		B port and V _{REF}	-0.5	4.6	v
V	Voltage range applied to any output in the high or power off state (2)	A port	-0.5	6.5	V
Vo	Voltage range applied to any output in the high or power-off state ⁽²⁾	B port	-0.5	4.6	v
	Current into any output in the law state	A port		48	~ ^
lo	Current into any output in the low state	B port		100	mA
I _O	Current into any A-port output in the high state ⁽³⁾			48	mA
	Continuous current through each V _{CC} or GND			±100	mA
I _{IK}	Input clamp current	V ₁ < 0		-50	mA
I _{OK}	Dutput clamp current V _O < 0			-50	mA
θ_{JA}	Package thermal impedance ⁽⁴⁾				°C/W
T _{stg}	Storage temperature range				°C

(1) Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

The current flows only when the output is in the high state and $V_O > V_{CC}$. The package thermal impedance is calculated in accordance with JESD 51-7. (3)

(4)

Recommended Operating Conditions⁽¹⁾⁽²⁾⁽³⁾⁽⁴⁾

			MIN	NOM	MAX	UNIT
V _{CC}	Supply voltage		3.15	3.3	3.45	V
V	Termination voltage	GTL	1.14	1.2	1.26	V
V _{TT}	Termination voltage	GTL+	1.35	1.5	1.65	v
V	Poforonoo voltogo	GTL	0.74	0.8	0.87	V
V _{REF}	Reference voltage	GTL+	0.87	1	1.1	v
V	V _I Input voltage	B port			V _{TT}	V
vI		Except B port			5.5	v
V		B port	V _{REF} + 50 mV			V
V _{IH}	High-level input voltage	Except B port	2			v
V	Low-level input voltage	B port			$V_{REF} - 50 \text{ mV}$	V
V _{IL}	Low-level input voltage	Except B port			0.8	v
I _{IK}	Input clamp current				–18	mA
I _{OH}	High-level output current	A port			-24	mA
		A port			24	mA
I _{OL}	Low-level output current	B port			50	ШA
T _A	Operating free-air temperature		-40		85	°C

(1) All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

Normal connection sequence is GND first and $V_{CC} = 3.3 \text{ V}$, I/O, control inputs, V_{TT} and V_{REF} (any order) last. V_{TT} and R_{TT} can be adjusted to accommodate backplane impedances if the dc recommended I_{OL} ratings are not exceeded. V_{REF} can be adjusted to optimize noise margins, but normally is two-thirds V_{TT} . (3)

(4)

SCBS673F-AUGUST 1996-REVISED APRIL 2005

Electrical Characteristics

over recommended operating free-air temperature range for GTL/GTL+ (unless otherwise noted)

PARAMETER	TEST	CONDITIONS	MIN TYP ⁽¹⁾	MAX	UNIT
	V _{CC} = 3.15 V,	I _I = -18 mA		-1.2	V
	$V_{CC} = 3.15 \text{ V} \text{ to } 3.45 \text{ V},$	I _{OH} = −100 μA	V _{CC} – 0.2		
A port	V 045 V	I _{OH} = -12 mA	2.4		V
	$v_{\rm CC} = 3.15 \rm v$	I _{OH} = -24 mA	2		
	V _{CC} = 3.15 V to 3.45 V,	I _{OL} = 100 μA		0.2	
A port	N 245 M	I _{OL} = 12 mA		0.4	
	$v_{\rm CC} = 3.15 \rm v$	I _{OL} = 24 mA		0.5	
	V_{CC} = 3.15 V to 3.45 V,	I _{OL} = 100 μA		0.2	V
D. nort		I _{OL} = 10 mA		0.2	
ь роп	V _{CC} = 3.15 V	I _{OL} = 40 mA		0.4	
		I _{OL} = 50 mA		0.55	
B port	V _{CC} = 3.45 V,	$V_{I} = V_{TT}$ or GND		±5	
A-port and control inputs	N 0.45 M	$V_I = V_{CC}$ or GND		±5	μA
	$v_{\rm CC} = 3.45 \text{ v}$	$V_{I} = 5.5 V \text{ or GND}$	±20		
L	V _{CC} = 0,	V_{I} or V_{O} = 0 to 5.5 V		100	μΑ
		V _I = 0.8 V	75		
A port	$V_{CC} = 3.15 V$	V _I = 2 V	-75		μΑ
	$V_{\rm CC} = 3.45 \ V^{(2)},$	$V_{I} = 0.8 V \text{ to } 2 V$		±500	
A port	V _{CC} = 3.45 V,	$V_{O} = V_{CC}$ or GND		±10	μΑ
B port	V _{CC} = 3.45 V,	V _O = 1.5 V		10	μΑ
	$V_{00} = 3.45 V$	Outputs high		60	
A or B port	$I_{0} = 0,$	Outputs low		60	mA
	$V_{I} = V_{CC}$ or GND	Outputs disabled		60	
	V_{CC} = 3.45 V, A-port or cor One input at V_{CC} – 0.6 V	ntrol inputs at V_{CC} or GND,		500	μA
Control inputs	V _I = 3.15 V or 0		2.5	3	pF
A port	V 245 V at 0		6	8	- 5
B port	$V_0 = 3.15 \text{ V or } 0$		6.5	8.5	pF
	A port A port B port B port A-port and control inputs A port A or B port A port	V _{CC} = 3.15 V, A port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ A port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ A port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ A port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ B port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ B port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ B port $V_{CC} = 3.15 V \text{ to } 3.45 V,$ A-port and control inputs $V_{CC} = 3.45 V,$ A-port and control inputs $V_{CC} = 3.45 V,$ A port $V_{CC} = 3.45 V,$ A or B port $V_{CC} = 3.45 V,$ $V_{C} = 0,$ $V_{C} = 3.45 V,$ $V_{C} = 0,$ $V_{C} = 3.45 V,$ $V_{C} = 0,$	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $

(1)

All typical values are at V_{CC} = 3.3 V, T_A = 25°C. This is the bus-hold maximum dynamic current. It is the minimum overdrive current required to switch the input from one state to (2) another.

For I/O ports, the parameter I_{OZ} includes the input leakage current. (3)

(4) This is the increase in supply current for each input that is at the specified TTL voltage level, rather than V_{CC} or GND.

SCBS673F-AUGUST 1996-REVISED APRIL 2005

Timing Requirements

over recommended ranges of supply voltage and operating free-air temperature for GTL (unless otherwise noted)

			MIN	MAX	UNIT
f _{clock}	f _{clock} Clock frequency			200	MHz
tw	Pulse duration, CLK high or low		2.5		ns
	Coture time	Data before CLK↑	2.1		
ι _{su}	Setup time	CE before CLK↑	3.3		ns
t _h	Hold time	Data after CLK1	0.3		20
	Hold time	0		ns	

Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature for GTL (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾ MAX	UNIT
f _{max}			200		MHz
t _{PLH}	CLKAB	В	2.5	5.5	ns
t _{PHL}	CERAB		2.2	5.5	115
t _{dis}	OEAB	D	1.7	4.8	20
t _{en}	OEAB	В	2.2	5.2	ns
Slew rate	Both transition	ons (B port)		0.5	V/ns
t _r	Transition time, B ou	Itputs (0.6 V to 1 V)	0.6	2.2	ns
t _f	Transition time, B ou	itputs (1 V to 0.6 V)	0.4	1.5	ns
t _{PLH}		٨	2.1	5.3	20
t _{PHL}	CLKBA	A	2.1	5	ns
t _{en}		٨	1.7	5	20
t _{dis}	OEBA	A	2.3	5.5	ns

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.



SCBS673F-AUGUST 1996-REVISED APRIL 2005

Timing Requirements

over recommended ranges of supply voltage and operating free-air temperature for GTL+ (unless otherwise noted)

			MIN	MAX	UNIT
f _{clock}	f _{clock} Clock frequency			200	MHz
tw	Pulse duration, CLK high or low		2.5		ns
	Coture time	Data before CLK↑	2.4		
ι _{su}	Setup time	CE before CLK↑	3.2		ns
t _h	Hold time	Data after CLK↑	0.2		
		0		ns	

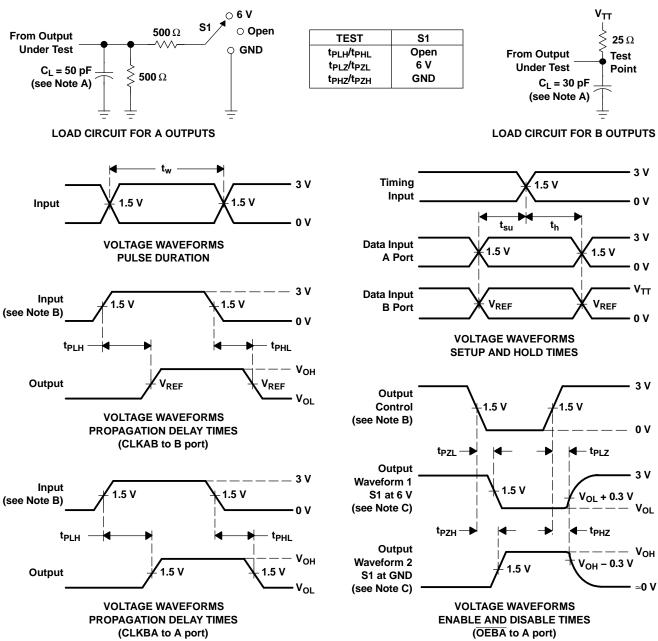
Switching Characteristics

over recommended ranges of supply voltage and operating free-air temperature for GTL+ (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP ⁽¹⁾	МАХ	UNIT
f _{max}			200			MHz
t _{PLH}	CLKAB	В	2.6	4	5.6	20
t _{PHL}	CERAB	D	2.3	4	5.7	ns
t _{PLH}	OEAB	D	2.4	3.8	5.2	20
t _{PHL}	- OEAB	В	1.8	3.4	5	ns
Slew rate	Both transition	Both transitions (B port)				V/ns
t _r	Transition time, B out	puts (0.6 V to 1.3 V)	1	1.6	2.7	ns
t _f	Transition time, B out	puts (1.3 V to 0.6 V)	0.5	1.1	3.2	ns
t _{PLH}		٨	2	3.8	5.3	
t _{PHL}	CLKBA	A	1.9	3.6	5	ns
t _{en}	- OEBA	٨	1.9	3.6	5	
t _{dis}	UEBA	A	2.1	4	5.5	ns

(1) All typical values are at V_{CC} = 3.3 V, T_A = 25°C.

SCBS673F-AUGUST 1996-REVISED APRIL 2005



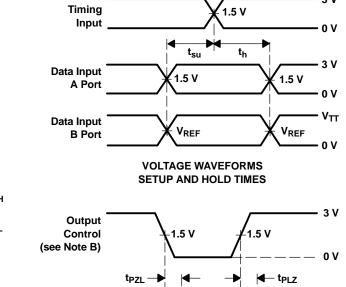
PARAMETER MEASUREMENT INFORMATION

NOTES: A. C₁ includes probe and jig capacitance.

- B. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z₀ = 50 Ω , t_r \leq 2.5 ns, t_f \leq 2.5 ns.
- C. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- D. The outputs are measured one at a time, with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

Texas **STRUMENTS** www.ti.com



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
74GTL16622ADGGRE4	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
74GTL16622ADGGRG4	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM
SN74GTL16622ADGGR	ACTIVE	TSSOP	DGG	64	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

Important Information and Disclaimer:The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

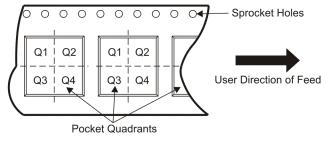
In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

TAPE AND REEL INFORMATION





QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal			
	_	-	

Device		Package Drawing			Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74GTL16622ADGGR	TSSOP	DGG	64	2000	330.0	24.4	8.4	17.3	1.7	12.0	24.0	Q1



PACKAGE MATERIALS INFORMATION

11-Mar-2008



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74GTL16622ADGGR	TSSOP	DGG	64	2000	346.0	346.0	41.0

MECHANICAL DATA

MTSS003D - JANUARY 1995 - REVISED JANUARY 1998

DGG (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

48 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold protrusion not to exceed 0,15.
- D. Falls within JEDEC MO-153



IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of TI information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

TI products are not authorized for use in safety-critical applications (such as life support) where a failure of the TI product would reasonably be expected to cause severe personal injury or death, unless officers of the parties have executed an agreement specifically governing such use. Buyers represent that they have all necessary expertise in the safety and regulatory ramifications of their applications, and acknowledge and agree that they are solely responsible for all legal, regulatory and safety-related requirements concerning their products and any use of TI products in such safety-critical applications, notwithstanding any applications-related information or support that may be provided by TI. Further, Buyers must fully indemnify TI and its representatives against any damages arising out of the use of TI products in such safety-critical applications.

TI products are neither designed nor intended for use in military/aerospace applications or environments unless the TI products are specifically designated by TI as military-grade or "enhanced plastic." Only products designated by TI as military-grade meet military specifications. Buyers acknowledge and agree that any such use of TI products which TI has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

TI products are neither designed nor intended for use in automotive applications or environments unless the specific TI products are designated by TI as compliant with ISO/TS 16949 requirements. Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, TI will not be responsible for any failure to meet such requirements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Clocks and Timers	www.ti.com/clocks	Digital Control	www.ti.com/digitalcontrol
Interface	interface.ti.com	Medical	www.ti.com/medical
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
RFID	www.ti-rfid.com	Telephony	www.ti.com/telephony
RF/IF and ZigBee® Solutions	www.ti.com/lprf	Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2008, Texas Instruments Incorporated